SLLS318C - NOVEMBER 1998 - REVISED JULY 2006

 3:21 Data Channel Expansion at up to 178.5 Mbytes/s Throughput 	D	GG PAC (TOP V	
 Suited for SVGA, XGA, or SXGA Display Data Transmission From Controller to Display With Very Low EMI 	D17 [D18 [GND [48 V _{CC} 47 D16 46 D15
 Three Data Channels and Clock Low-Voltage Differential Channels In and 21 Data and Clock Low-Voltage TTL Channels Out 	D19 [D20 [NC [3 4 5 6 7	46 D13 45 D14 44 GND 43 D13 42 V _{CC}
 Operates From a Single 3.3-V Supply Tolerates 4-kV HBM ESD 	A0M	8 9	41 D12 40 D11
 Packaged in Thin Shrink Small-Outline Package (TSSOP) With 20-Mil Terminal Pitch 	A1P [LVDSV _{CC} [10 11 12	39 D10 38 GND 37 D9
 Consumes Less Than 1 mW When Disabled 	LVDSGND	1	36 V _{CC}
 Wide Phase-Lock Input Frequency Range 31 MHz to 68 MHz 	A2M [A2P [CLKINM [14 15 16	35 D8 34 D7 33 D6
 No External Components Required for PLL 			32 GND
 Inputs Meet or Exceed the Standard Requirements of ANSI EIA/TIA-644 Standard 	LVDSGND [PLLGND [PLLV _{CC} [-	31 05 30 04 29 03
 Improved Replacement for the DS90C364 and SN75LVDS86 	PLLGND [SHTDN [21 22	28 V _{CC} 27 D2
Improved Jitter Tolerance	CLKOUT [1	26 D1
 Available in Q-Temp Automotive High Reliability Automotive Applications 	D0 [<u> </u>	25 GND

NC - Not connected

description

The SN65LVDS86AQ/SN75LVDS86A FlatLink receiver contains three serial-in 7-bit parallel-out shift registers and four low-voltage differential signaling (LVDS) line receivers in a single integrated circuit. These functions allow receipt of synchronous data from a compatible transmitter, such as the SN75LVDS81, '83, '84, or '85, over four balanced-pair conductors and expansion to 21 bits of single-ended low-voltage LVTTL synchronous data at a lower transfer rate.

When receiving, the high-speed LVDS data is received and loaded into registers at seven times the LVDS input clock (CLKIN) rate. The data is then unloaded to a 21-bit wide LVTTL parallel bus at the CLKIN rate. The 'LVDS86A presents valid data on the falling edge of the output clock (CLKOUT).

The 'LVDS86A requires only four line-termination resistors for the differential inputs and little or no control. The data bus appears the same at the input to the transmitter and output of the receiver with the data transmission transparent to the user(s). The only user intervention is the possible use of the shutdown/clear (SHTDN) active-low input to inhibit the clock and shut off the LVDS receivers for lower power consumption. A low level on this signal clears all internal registers to a low level.



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Configuration Control / Print Support Qualification to Automotive Standards

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



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SLLS318C - NOVEMBER 1998 - REVISED JULY 2006

The SN75LVDS86A is characterized for operation over ambient free-air temperatures of 0° C to 70° C. The SN65LVDS86AQ is characterized for operation over the full Automotive temperature range of -40° C to 125° C.

functional block diagram



Input Bus



SLLS318C - NOVEMBER 1998 - REVISED JULY 2006



Figure 1. SN65LVDS86AQ/SN75LVDS86A Load and Shift Timing Sequences

equivalent input and output schematic diagrams





SLLS318C - NOVEMBER 1998 - REVISED JULY 2006

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V _{CC} (see Note 1)	
Voltage range at any terminal	–0.5 V to V _{CC} + 0.5 V
Electrostatic discharge (see Note 2): All pins (Class 3A) .	
All pins (Class 2B) .	
Continuous total power dissipation	See Dissipation Rating Table
Operating virtual junction temperature range, T _J	–40°C to 150°C
Storage temperature range, T _{stg}	–65°C to 150°C
Lead temperature 1,6 mm (1/16 in) from case for 10 s	

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltage values are with respect to the GND terminals unless otherwise noted.

2. This rating is measured using MIL-STD-883C Method, 3015.7.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C	DERATING FACTOR [‡]	T _A = 70°C	T _A = 125°C
	POWER RATING	ABOVE T _A = 25°C	POWER RATING	POWER RATING
DGG	1637 mW	13.1 mW/°C	1048 mW	327 mW

[‡] This is the inverse of the junction-to-ambient thermal resistance when board mounted and with no air flow.

recommended operating conditions (see Figure 2)

		MIN	NOM	MAX	UNIT
Supply voltage, V _{CC}		3	3.3	3.6	V
High-level input voltage, VIH (SHTDN)		2			V
Low-level input voltage, VIL (SHTDN)				0.8	V
Magnitude differential input voltage, VID		0.1		0.6	V
Common-mode input voltage, VIC		$\frac{ V_{ID} }{2}$	2	$2.4 - \frac{ V_{ID} }{2}$	V
	SN75LVDS86A	0		70	
Operating free-air temperature, T _A	SN65LVDS86AQ	-40		125	°C

timing requirements

	MIN	NOM	MAX	UNIT
Cycle time, input clock, t_{C} §	14.7	t _C	32.4	ns

§ Parameter $t_{\mbox{C}}$ is defined as the mean duration of a minimum of 32 000 clock cycles.



SLLS318C - NOVEMBER 1998 - REVISED JULY 2006

			•				
	PARAMETER	TEST	CONDITIONS	MIN	TYP†	MAX	UNIT
V _{IT+}	Positive-going differential input threshold voltage					100	mV
V _{IT} -	Negative-going differential input threshold voltage \ddagger			-100			mV
Vон	High-level output voltage	$I_{OH} = -4 \text{ mA}$		2.4			V
VOL	Low-level output voltage	$I_{OL} = 4 \text{ mA}$				0.4	V
	Disabled,	All inputs to GND			280	μΑ	
	CC Quiescent current (average)	Enabled, AnM = 1.4 V,	,		33	40	
ICC		Enabled, $C_L = 8 \text{ pF}$, Grayscale pattern (see Figure 3), $t_C = 15.38 \text{ ns}$			43		mA
	Enabled, Worst-case p t _C = 15.38 ns	C _L = 8 pF, attern (see Figure 4)		68			
IIН	High-level input current (SHTDN)	$V_{IH} = V_{CC}$				±20	μA
		N/ O	SN75LVDS86A			±20	
ΙIL	L Low-level input current (SHTDN)	$V_{IL} = 0$	SN65LVDS86AQ			±25	μA
Ι	Input current A inputs	$0 \le V_I \le 2.4 V$				±20	μA
IOZ	High-impedance output current	$V_{O} = 0 \text{ or } V_{O}$	C			±10	μΑ

electrical characteristics over recommended operating conditions (unless otherwise noted)

[†] All typical values are at V_{CC} = 3.3 V, T_A = 25°C.

[‡] The algebraic convention, in which the less-positive (more-negative) limit is designated minimum, is used in this data sheet for the negative-going input voltage threshold only.

switching characteristics over recommended operating conditions (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP†	MAX	UNIT
t _{su}	Setup time, D0–D20 to CLKOUT \downarrow		5			ns
t _h	Data hold time, CLKOUT \downarrow to D0–D20	C _L = 8 pF, See Figure 5	5			ns
^t (RSKM)	Receiver input skew margin§ (see Figure 7)	t _c = 15.38 ns (±0.2%), ∣Input clock jitter∣ < 50 ps¶,	550	700		ps
td	Delay time, CLKIN \uparrow to CLKOUT \downarrow (see Figure 7)	V_{CC} = 3.3 V, t _c = 15.38 ns (±0.2%), T _A = 25°C	3	5	7	ns
t _{en}	Enable time, SHTDN to phase lock	See Figure 7		1		ms
^t dis	Disable time, SHTDN to off state	See Figure 8		400		ns
tt	Transition time, output (10% to 90% t_r or t_f) (data only)	CL = 8 pF		3		ns
tt	Transition time, output (10% to 90% $t_{f} \mbox{ or } t_{f})$ (clock only)	C _L = 8 pF		1.5		ns
tw	Pulse duration, output clock			0.50 t _C		ns

[†] All typical values are at V_{CC} = 3.3 V, T_A = 25° C.

§ The parameter t_(RSKM) is the timing margin available to allocate to the transmitter and interconnection skews and clock jitter. The value of this parameter at clock periods other than 15.38 ns can be calculated from t_{RSKM} = tc/14 – 550 ps.

 \P [Input clock jitter] is the magnitude of the change in input clock period.



SN65LVDS86AQ, SN75LVDS86A FlatLink[™] RECEIVER

SLLS318C - NOVEMBER 1998 - REVISED JULY 2006

PARAMETER MEASUREMENT INFORMATION



Figure 2. Voltage Definitions









NOTE A: The worst-case test pattern produces nearly the maximum switching frequency for all of the LVTTL outputs.

Figure 4. Worst-Case Test-Pattern Waveforms



SLLS318C - NOVEMBER 1998 - REVISED JULY 2006



Figure 5. Setup and Hold Time Waveforms



SLLS318C - NOVEMBER 1998 - REVISED JULY 2006



PARAMETER MEASUREMENT INFORMATION

NOTE A: CLKIN is advanced or delayed with respect to data until errors are observed at the receiver outputs. The advance or delay is then reduced until there are no data errors observed. The magnitude of the advance or delay is t_(RSKM).

Figure 6. Receiver Input Skew Margin, Setup/Hold Time, and Delay Time Definitions



SLLS318C - NOVEMBER 1998 - REVISED JULY 2006



PARAMETER MEASUREMENT INFORMATION





SLLS318C - NOVEMBER 1998 - REVISED JULY 2006



TYPICAL CHARACTERISTICS

Figure 9. RMS Grayscale I_{CC} vs Clock Frequency



SLLS318C - NOVEMBER 1998 - REVISED JULY 2006



APPLICATION INFORMATION

NOTES: A. The four 100- Ω terminating resistors are recommended to be 0603 types. B. NA - not applicable, these unused inputs should be left open.

Figure 10. 18-Bit Color Host to Flat Panel Display Application



SLLS318C - NOVEMBER 1998 - REVISED JULY 2006



APPLICATION INFORMATION

NOTES: A. The four $100-\Omega$ terminating resistors are recommended to be 0603 types. B. NA - not applicable, these unused inputs should be left open.

Figure 11. 24-Bit Color Host to 18-Bit Color LCD Panel Display Application

See the FLatLink Designer's Guide (SLLA012) for more application information.



PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
SN65LVDS86AQDGG	ACTIVE	TSSOP	DGG	48	40	TBD	CU NIPDAU	Level-1-220C-UNLIM
SN65LVDS86AQDGGR	ACTIVE	TSSOP	DGG	48	2000	TBD	CU NIPDAU	Level-1-220C-UNLIM
SN75LVDS86ADGG	ACTIVE	TSSOP	DGG	48	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
SN75LVDS86ADGGG4	ACTIVE	TSSOP	DGG	48	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
SN75LVDS86ADGGR	ACTIVE	TSSOP	DGG	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
SN75LVDS86ADGGRG4	ACTIVE	TSSOP	DGG	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details. **TBD:** The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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MECHANICAL DATA

MTSS003D - JANUARY 1995 - REVISED JANUARY 1998

DGG (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

48 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-153



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